

Notice of References Cited	Application/Control No. 10/649,516	Applicant(s)/Patent Under Reexamination STEIJER ET AL.	
	Examiner Derek L. Dupuis	Art Unit 2883	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,309,113 B1	10-2001	Naito, Katsuyoshi	385/88
*	C	US-5,675,685	10-1997	Fukuda et al.	385/89
*	D	US-6,945,709 B2	09-2005	Steijer et al.	385/92
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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